


<b>Search Notes</b> 	<b>Application/Control No.</b> 10528474	<b>Applicant(s)/Patent Under Reexamination</b> TEE ET AL.
	<b>Examiner</b> NIKETA I PATEL	<b>Art Unit</b> 2181

### SEARCHED

Class	Subclass	Date	Examiner
710	8	5/11/2008	NIP
710	8	12/21/2008	NIP
710	8	6/5/2009	NIP

### SEARCH NOTES

Search Notes	Date	Examiner
East - all the databases searched	5/11/2008	NIP
Inventor Search	5/11/2008	NIP
Updated: East	12/21/2008	NIP
Updated: Inventor Search	12/21/2008	NIP
Updated: East	6/5/2009	NIP
Updated: Inventor Search	6/5/2009	NIP
EIC-TC2100 - way back search to find TransDimension reference.	3/24/2009	

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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